# 2SD1276, 2SD1276A

## Silicon NPN triple diffusion planar type darlington

For power amplification

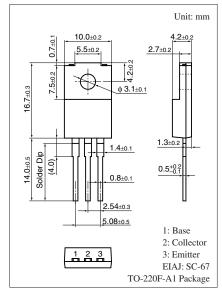
Complementary to 2SB0950 and 2SB0950A

#### ■ Features

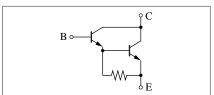
- High forward current transfer ratio h<sub>FE</sub>
- High-speed switching
- Full-pack package which can be installed to the heat sink with one screw

### ■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit	
Collector-base voltage	2SD1276	$V_{CBO}$	60	V
(Emitter open)	2SD1276A		80	
Collector-emitter voltage	2SD1276	V <sub>CEO</sub>	60	V
(Base open)	2SD1276A		80	
Emitter-base voltage (Col	$V_{EBO}$	5	V	
Collector current	$I_C$	4	A	
Peak collector current	$I_{CP}$	8	A	
Collector power	$T_C = 25^{\circ}C$	P <sub>C</sub>	40	W
dissipation		2.0		
Junction temperature	T <sub>j</sub>	150	°C	
Storage temperature	$T_{stg}$	-55 to +150	°C	



#### Internal Connection



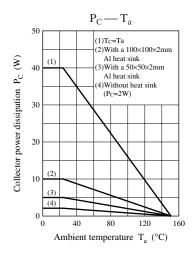
### ■ Electrical Characteristics $T_a = 25$ °C $\pm 3$ °C

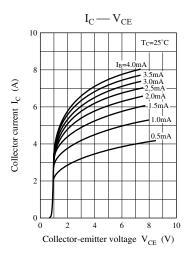
Parameter		Symbol	Conditions	Min	Тур	Max	Unit
Collector-emitter voltage	2SD1276	V <sub>CEO</sub>	$I_C = 30 \text{ mA}, I_B = 0$	60			V
(Base open)	2SD1276A			80			
Base-emitter voltage		$V_{BE}$	$V_{CE} = 3 \text{ V}, I_{C} = 3 \text{ A}$			2.5	V
Collector-base cutoff	2SD1276	$I_{CBO}$	$V_{CB} = 60 \text{ V}, I_{E} = 0$			200	μΑ
current (Emitter open)	2SD1276A		$V_{CB} = 80 \text{ V}, I_{E} = 0$			200	
Collector-emitter cutoff	2SD1276	$I_{CEO}$	$V_{CE} = 30 \text{ V}, I_{B} = 0$			500	μΑ
current (Base open)	2SD1276A		$V_{CE} = 40 \text{ V}, I_{B} = 0$			500	
Emitter-base cutoff current (Collector open)		$I_{EBO}$	$V_{EB} = 5 \text{ V}, I_{C} = 0$			2	mA
Forward current transfer ratio		h <sub>FE1</sub>	$V_{CE} = 3 \text{ V}, I_{C} = 0.5 \text{ A}$	1 000			_
		h <sub>FE2</sub> *	$V_{CE} = 3 \text{ V}, I_{C} = 3 \text{ A}$	1 000		10 000	
Collector-emitter saturation voltage		V <sub>CE(sat)1</sub>	$I_C = 3 \text{ A}, I_B = 12 \text{ mA}$			2.0	V
		V <sub>CE(sat)2</sub>	$I_C = 5 \text{ A}, I_B = 20 \text{ mA}$			4.0	
Transition frequency		$f_T$	$V_{CE} = 10 \text{ V}, I_{C} = 0.5 \text{ A}, f = 1 \text{ MHz}$		20		MHz
Turn-on time		t <sub>on</sub>	$I_C = 3 \text{ A}, I_{B1} = 12 \text{ mA}, I_{B2} = -12 \text{ mA},$		0.5		μs
Storage time		t <sub>stg</sub>	$V_{CC} = 50 \text{ V}$		4.0		μs
Fall time		t <sub>f</sub>			1.0		μs

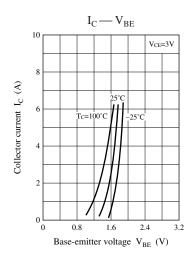
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

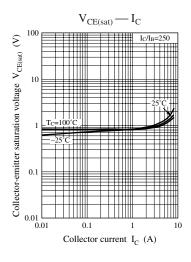
#### 2. \*: Rank classification

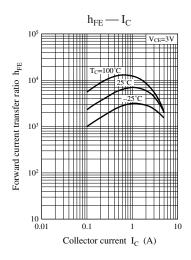
Rank	R	Q	Р
h <sub>FE2</sub>	1000 to 2500	2000 to 5000	4000 to 10000

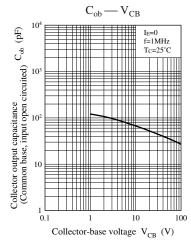


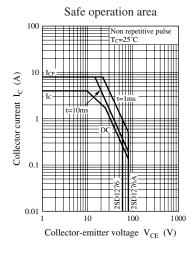


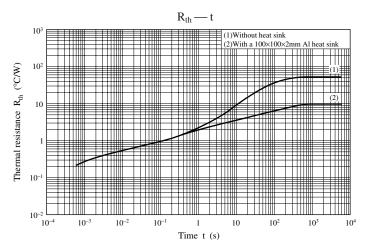












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